Application/Control No. Applicant(s)/Patent Under Reexamination 10/564,626 OGAWA ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 2827 Thong Q. Le **U.S. PATENT DOCUMENTS Document Number** Date Name Classification Country Code-Number-Kind Code MM-YYYY US-2001/0055233 12-2001 Nagai, Takeshi 365/225.7 Α * 11-2000 US-6,154,389 Chung et al. 365/185.09 В * 09-2000 365/185.09 Chung et al. US-6,122,194 С * 08-1996 365/230.04 US-5,546,349 Watanabe et al. D US-5,532,966 07-1996 Poteet et al. 365/200 E US-F US-US-Н US) Ī US-J US-Κ US-L US-М FOREIGN PATENT DOCUMENTS **Document Number** Date Name Classification Country Country Code-Number-Kind Code MW-YYYY Ν 0 Ρ Q R s Т NON-PATENT DOCUMENTS Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U V W Х

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